

4.30

24X

DIMENSIONS: MILLIMETERS

0.32

DATE 05 JUN 2012

NOTES:

- DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994.
- T14-3M, 1994. CONTROLLING DIMENSION: MILLIMETERS. DIMENSION 6 APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.25 AND 0.30 MM FROM THE TERMINAL TIP.
- COPLANARITY APPLIES TO THE EXPOSED PAD AS WELL AS THE TERMINALS.

	MILLIMETERS		
DIM	MIN	MAX	
Α	0.80	1.00	
A1	0.00	0.05	
A3	0.20 REF		
b	0.20	0.30	
D	4.00 BSC		
D2	2.70	2.90	
Е	4.00 BSC		
E2	2.70	2.90	
е	0.50 BSC		
L	0.30	0.50	
L1	0.05	0.15	

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code

= Assembly Location Α

= Wafer Lot L

Υ = Year W = Work Week

= Pb-Free Package

(Note: Microdot may be in either location)

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot " ■", may or may not be present.

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2.90

0.50

PITCH